

CHIP COIL (CHIP INDUCTORS) LQW18AN□□□□1ZD Murata Standard Reference Specification 【AEC-Q200】

1.Scope

This reference specification applies to LQW18AN_1ZD series, Chip coil(Chip Inductors) for automotive Electronics based on AEC-Q200 except for Power train and Safety.

2.Part Numbering

(ex) LQ W I8 Applications Category Inductance Tolerance Features Application Z:Automotive D:Taping

3.Rating

Operating Temperature Range.
 Storage Temperature Range.
 -55°C to +125°C
 -55°C to +125°C

Clorage remperature range.								
MURATA Part Number	(Ref	er to below	Q (*1)	DC Resistance (*1)	Self Resonant Frequency (*1)	Rated Current	ESD Rank	
	(nH)	Tolerance	(min.)	(Ω max.)	(MHz min.)	(mA)	6: 25kV	
LQW18AN2N2D1ZD	2.2	D:±0.5nH	25	0.018	18000	1400		
LQW18AN3N9C1ZD	2.0	C:±0.2nH		0.022	11000	1000		
LQW18AN3N9D1ZD	ა.9	D:±0.5nH		0.032	11000	1000		
LQW18AN5N6D1ZD	5.6	D:±0.5nH			10000			
LQW18AN6N8C1ZD	6.0	C:±0.2nH		0.045		900		
LQW18AN6N8D1ZD	0.0	D:±0.5nH	38 -		5000			
LQW18AN8N2D1ZD	8.2	D:±0.5nH						
LQW18AN10NG1ZD	10			0.058		800	6	
LQW18AN10NJ1ZD	10	G:±2%						
LQW18AN12NG1ZD	12	J:±5%		0.071		750		
LQW18AN12NJ1ZD	12			0.071				
LQW18AN15NJ1ZD	15	J:±5%			4500]		
LQW18AN18NG1ZD	10			0.085	2500	700		
LQW18AN18NJ1ZD	10				3300			
LQW18AN22NG1ZD	22 G:±2% J:±5%		J:±5%	42	0.000	3200	640	
LQW18AN22NJ1ZD				42	0.099	3200	040	
LQW18AN27NG1ZD					0.116	2800	500	
LQW18AN27NJ1ZD	21			0.116	2000	590		
LQW18AN33NJ1ZD	33	J:±5%		0.132	2500	550		
	MURATA Part Number LQW18AN2N2D1ZD LQW18AN3N9C1ZD LQW18AN3N9D1ZD LQW18AN5N6D1ZD LQW18AN6N8C1ZD LQW18AN6N8D1ZD LQW18AN6N8D1ZD LQW18AN10NG1ZD LQW18AN10NJ1ZD LQW18AN12NJ1ZD LQW18AN12NJ1ZD LQW18AN15NJ1ZD LQW18AN18NG1ZD LQW18AN18NG1ZD LQW18AN18NJ1ZD LQW18AN22NJ1ZD LQW18AN22NJ1ZD LQW18AN22NJ1ZD LQW18AN22NJ1ZD LQW18AN27NJ1ZD	MURATA Part Number MURATA Part Number C.C. (nH)	MURATA Part Number	MURATA Part Number	Inductance(*1) (Refer to below Comment) (Min.) Tolerance (*1) (Ω max.)	MURATA Part Number	MURATA Part Number	

(*1)

Standard Testing Conditions

《Unless otherwise specified》

Temperature : Ordinary Temperature / 15°C to 35°C

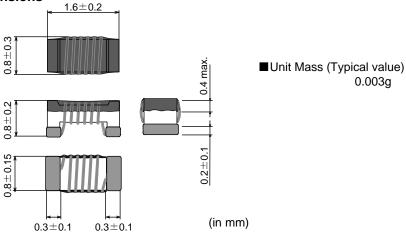
Humidity : Ordinary Humidity / 25%(RH) to 85%(RH)

《In case of doubt》

Temperature : 20°C±2°C

Humidity : 60%(RH) to 70%(RH) Atmospheric Pressure : 86kPa to 106 kPa

4. Appearance and Dimensions



5.Electrical Performance

No.	Item	Specification	Test Method
5.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: Agilent 4991A or equivalent Measuring Frequency: <inductance> 100MHz <q> 250MHz Measuring Condition: Test signal level / about 0dBm Electrical length / 0.94cm Measuring Fixture: Agilent 16193A Position coil under test as shown in below and contact coil with each terminal by adding weight.</q></inductance>
5.2	Q	Q shall meet item 3.	6.97mm Measuring Method:See P.10 <electrical inductance="" method="" of="" performance:measuring="" q=""></electrical>
5.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment:Digital multi meter
5.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: Agilent 5230A or equivalent
5.5	Rated Current	Self temperature rise shall be limited to 20°C max. Inductance Change: within ±10%	The rated current is applied.



6.Q200 Requirement

6.1.Performance (based on Table 5 for Magnetics(Inductors / Transformer) AEC-Q200 Rev.D issued June 1. 2010

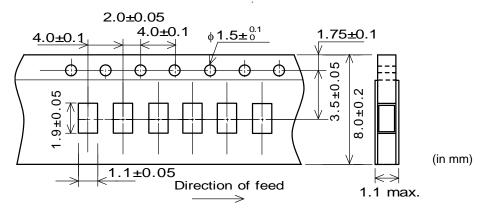
	Δ	AEC-Q200	Murata Specification / Deviation	
No	No Stress Test Method		Indiata Specification / Deviation	
	High	1000hours at 125 deg C	Meet Table A after testing.	
٦	Temperature	Set for 24hours at room	T 11 A	
	Exposure	temperature, then measured.	Appearance No damage	
	1		Inductance (at 100MHz) Within ±5%	
			(at 1001VII 12)	
1	Tomporoturo	10000 / clos	Most Table A ofter testing	
4	Temperature Cycling	1000cycles -40 deg C to +125 deg C	Meet Table A after testing.	
	Cyoming .	Set for 24hours at room		
		temperature,then		
		measured.		
7	Biased Humidity	1000hours at 85 deg C,	Meet Table A after testing.	
		85%RH		
		unpowered		
8	Operational Life	Apply Rated Current 125 deg	Meet Table A after testing	
Ĭ	Sporational Life	C 1000hours	initial region to the country.	
		Set for 24hours at room		
		temperature, then measured		
9	External Visual	Visual inspection	No abnormalities	
10	Physical	Meet ITEM 4	No defects	
"	Dimension	(Style and Dimensions)		
		(1.5)		
12	Resistance	Per	Not Applicable	
	to Solvents	MIL-STD-202		
12	Mechanical Shock	Method 215	Meet Table A after testing.	
13	Medianical Shock	Method 213	weet Table A after testing.	
		Condition C : 100g's(0.98N),		
		6ms, Half sine, 12.3ft/s		
14	Vibration	5g's(0.049N) for 20 minutes	Meet Table A after testing.	
		12cycles each of 3		
		orientations		
		Test from 10-2000Hz.		
15	Resistance	No-heating	Pre-heating: 150C +/-10 deg C, 60s to 90s	
13		Solder temperature	Meet Table A after testing.	
	lo coldoning riodi	260C+/-5 deg C	in our radio / artor tooting.	
		Immersion time 10s		
47	CCD	Dor AEC 0000 000	ECD Donly Defends Name 2. Define	
[17	ESD	Per AEC-Q200-002	ESD Rank: Refer to Item 3. Rating. Meet Table A after testing.	
			ivice: Table A after testing.	
18	Solderbility	Per J-STD-002	Method b : Not Applicable	
. Ŭ	25.45.5	. 5. 3 5. 2 552	95% of the terminations is to be soldered.	
			(Except exposed wire)	
10	Floatrical	Magazirad : Indicatanas	No defects	
19	Electrical Characterization	Measured : Inductance	INO defects	
	Ondidottization			
Ь	I	1	I .	

Reference Only

AEC-Q200		Murata Specification / Deviation				
No	Stress	Test Method				
20	Flammability	Per UL-94	Not Applicable			
21		Epoxy-PCB(1.6mm) Deflection 2mm(min)	Meet Table B after testing. Table B			
		Holding time 60s		Appearance	No damage	
				DC resistance change	Within ±10%	
22	_		Murata Deviation Request: 10N/5s No defect			

7. Specification of Packaging

7.1 Appearance and Dimensions of paper tape (8mm-wide)



7.2 Specification of Taping

- (1) Packing quantity (standard quantity)
 - 4,000 pcs. / reel
- (2) Packing Method

Products shall be packed in the cavity of the base tape and sealed by top tape and bottom tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Base tape and Top tape has no spliced point.

(5) Missing components number

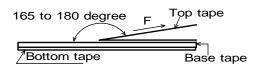
Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

7.3 Pull Strength

Top tape	5N min.
Bottom tape	SIN IIIIII.

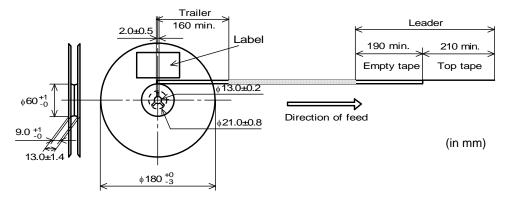
7.4 Peeling off force of cover tape

Speed of Peeling off	300mm/min
Peeling off force	0.1N to 0.6N
	(minimum value is typical)



7.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.



7.6 Marking for reel

Customer part number, MURATA part number, Inspection number(*1) , RoHS Marking (*2), Quantity etc \cdots

*1) < Expression of Inspection No.>

 $\frac{\square \square}{(1)} \quad \frac{OOOO}{(2)} \quad \frac{\times \times \times}{(3)}$

(1) Factory code

(2) Date First digit : Year / Last digit of year

Second digit : Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O,N,D

Third, Fourth digit: Day

(3) Serial No.

*2) <Expression of RoHS Marking >

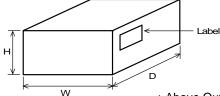
ROHS
$$-\underline{Y}(\underline{\Delta})$$
(1) (2)

- (1) RoHS regulation conformity parts.
 - (2) MURATA classification number

7.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS Marking (*2) ,Quantity, etc \cdots

7.8. Specification of Outer Case



Outer Case Dimensions (mm)			Standard Reel Quantity in Outer Case (Reel)
W	D	Н	III Outer Case (Reel)
186	186	93	5

* Above Outer Case size is typical. It depends on a quantity of an order.

8. / Caution

8.1 Caution(Rating)

Do not exceed maximum rated current of the product. Thermal stress may be transmitted to the product and short/open circuit of the product or falling off the product may be occurred.

8.2 Fail-safe

Be sure to provide an appropriate fail-safe function on your product to prevent a second damage that may be caused by the abnormal function or the failure of our product.



8.3 Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

(1) Aircraft equipment (6) Transportation equipment (trains, ships, etc.)

(2) Aerospace equipment (7) Traffic signal equipment

(3) Undersea equipment (8) Disaster prevention / crime prevention equipment

(4) Power plant control equipment (9) Data-processing equipment

(5) Medical equipment (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

9. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

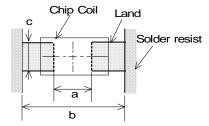
Please consult us in advance for applying other mounting method such as conductive adhesive.

9.1 Land pattern designing

Recommended land patterns for reflow soldering are as follows:

These have been designed for Electric characteristics and solderability.

Please follow the recommended patterns. Otherwise, their performance which includes electrical performance or solderability may be affected, or result to "position shift" in soldering process.



0.6 to 0.8
1.9 to 2.0
0.7 to 1.0

(in mm)

9.2 Flux, Solder

· Use rosin-based flux.

Includes middle activator equivalent to 0.06(wt)% to 0.1(wt)% Chlorine.

Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value).

Don't use water-soluble flux.

- · Use Sn-3.0Ag-0.5Cu solder.
- Standard thickness of solder paste : $100 \,\mu$ m to $150 \,\mu$ m.

9.3 Reflow soldering conditions

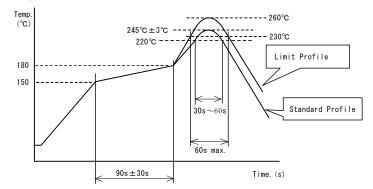
 Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max.

Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.

· Standard soldering profile and the limit soldering profile is as follows.

The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.

· Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C~180°C	C 、90s±30s
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C,10s
Cycle of reflow	2 times	2 times

9.4 Reworking with soldering iron

The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C,1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	ϕ 3mm max.
Soldering time	3(+1,-0)s
Time	2 times

Note :Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

9.5 Solder Volume

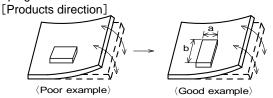
- Solder shall be used not to be exceeded the upper limits as shown below.
- Accordingly increasing the solder volume, the mechanical stress to Chip is also increased.
 Exceeding solder volume may cause the failure of mechanical or electrical performance.



9.6 Product's location

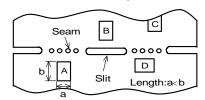
The following shall be considered when designing and laying out P.C.B.'s.

(1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.



Products shall be located in the sideways direction (Length:a < b) to the mechanical stress.

(2) Products location on P.C.B. separation



Products (A,B,C,D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board. Because they may be subjected the mechanical stress in order of $A>C>B\cong D$.



9.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max.(40°C max for IPA)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - 1. Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent

PINE ALPHA ST-100S

- (4) There shall be no residual flux and residual cleaner after cleaning.
 - In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

9.8 Resin coating

The inductance value may change due to high cure-stress of resin to be used for coating/molding products. An open circuit issue may occur by mechanical stress caused by the resin, amount/cured shape of resin, or operating condition etc. Some resin contains some impurities or chloride possible to generate chlorine by hydrolysis under some operating condition may cause corrosion of wire of coil, leading to open circuit. So, please pay your careful attention when you select resin in case of coating/molding the products with the resin. Prior to use the coating resin, please make sure no reliability issue is observed by evaluating products mounted on your board.

9.9 Caution for use

- Sharp material such as a pair of tweezers or other material such as bristles of cleaning brush, shall not be touched to the winding portion to prevent the breaking of wire.
- · Mechanical shock should not be applied to the products mounted on the board to prevent the breaking of the core.

9.10 Notice of product handling at mounting

In some mounting machines, when picking up components support pin pushes up the components from the bottom of base tape. In this case, please remove the support pin. The support pin may damage the components and break wire.

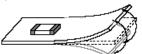
In rare case ,the laser recognition can not recognize this component. Please contact us when you use laser recognition. (There is no problem with the permeation and reflection type.)

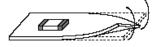
9.11 Handling of a substrate

After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

Bending Twisting







9.12 Storage and Handing Requirements

(1) Storage period

Use the products within 12 months after delivered.

Solderability should be checked if this period is exceeded.

(2) Storage conditions

Products should be stored in the warehouse on the following conditions.

Temperature : -10°C to 40°C

Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity

- Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- Products should not be stored on bulk packaging condition to prevent the chipping of the core and the breaking of winding wire caused by the collision between the products.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- · Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- (3) Handling Condition

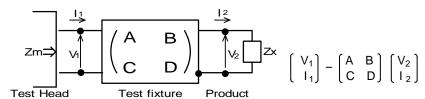
Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

10. <u>A</u> Note

- (1)Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2)You are requested not to use our product deviating from the reference specifications.
- (3)The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

<Electrical Performance:Measuring Method of Inductance / Q> -

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1} \qquad , \qquad Zx = \frac{V_2}{I_2}$$

(3) Thus, the relation between Zx and Zm is following;

$$Zx=\alpha \frac{Zm-\beta}{1-Zm\,\Gamma} \hspace{1cm} where, \alpha = D \ / \ A = 1 \\ \beta = B \ / \ D = Zsm-(1-Yom \ Zsm)Zss \\ \Gamma = C \ / \ A = Yom$$

Zsm:measured impedance of short chip
Zss:residual impedance of short chip (0.771nH)
Yom:measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.

$$Lx = \frac{Im(Zx)}{2 \pi f} \quad , \quad Qx = \frac{Im(Zx)}{Re(Zx)} \quad Lx : Inductance of chip coil \\ Qx:Q of chip coil \\ f : Measuring frequency$$